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PATENT

450100-05108

BT01 Rec'd PCT/PTC 09 FEB 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Hisao TANAKA et al.
International Application No.: PCT/JP2004/008394
International Filing Date: June 9, 2004
For: RECORDING CONTROL APPARATUS AND
METHOD, PROGRAM, AND RECORDING MEDIUM

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Sir:

Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP2004/008394. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

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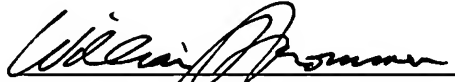
REMARKS

Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450100-05108	Serial No. 10/524227 Filed Concurrently Herewith
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LIST OF REFERENCES CITED BY APPLICANT
(Use several sheets if necessary)

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AF	JP 2002-57979	02/22/02	Japan			
	AG	WO 00/14740	03/16/00	PCT			
	AH	EP 1 118 998	07/25/01	Europe			
	AI	WO 02/21845	03/14/02	PCT			
	AJ	JP 2004-508777	03/18/04	Japan			
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	AM	JP 2004-112425	04/08/04	Japan			
	AN	EP 1 427 217	06/09/04	Europe			
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